# IEEE802.3af Compatible

## FEATURES

- ❑ Avalanche Rugged Technology
- ❑ Rugged Gate Oxide Technology
- ❑ Lower Input Capacitance
- ❑ Improved Gate Charge
- ❑ Extended Safe Operating Area
- ❑ Lower Leakage Current : 10 μA (Max.) @ $V_{DS}$ = 100V
- ❑ Lower $R_{DS(ON)}$ : 0.155 Ω (Typ.)

$BV_{DSS}$ = 100 V

$R_{DS(on)}$ = 0.2 Ω

$I_D$ = 2.3 A

**SOT-223**


**1. Gate 2. Drain 3. Source**

## Absolute Maximum Ratings

| Symbol | Characteristic | Value | Units |
|---|---|---|---|
| $V_{DSS}$ | Drain-to-Source Voltage | 100 | V |
| $I_D$ | Continuous Drain Current ($T_A$=25℃) | 2.3 | A |
| | Continuous Drain Current ($T_A$=70℃) | 1.84 | |
| $I_{DM}$ | Drain Current-Pulsed ① | 18 | A |
| $V_{GS}$ | Gate-to-Source Voltage | ±20 | V |
| $E_{AS}$ | Single Pulsed Avalanche Energy ② | 123 | mJ |
| $I_{AR}$ | Avalanche Current ① | 2.3 | A |
| $E_{AR}$ | Repetitive Avalanche Energy ① | 0.24 | mJ |
| dv/dt | Peak Diode Recovery dv/dt ③ | 6.5 | V/ns |
| $P_D$ | Total Power Dissipation ($T_A$=25℃) * | 2.4 | W |
| | Linear Derating Factor * | 0.019 | W/℃ |
| $T_J$ , $T_{STG}$ | Operating Junction and Storage Temperature Range | - 55 to +150 | ℃ |
| $T_L$ | Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5-seconds | 300 | |

## Thermal Resistance

| Symbol | Characteristic | Typ. | Max. | Units |
|---|---|---|---|---|
| $R_{\theta JA}$ | Junction-to-Ambient * | -- | 52 | ℃/W |

* When mounted on the minimum pad size recommended (PCB Mount).

## Electrical Characteristics ($T_A$=25℃ unless otherwise specified)

| Symbol | Characteristic | Min. | Typ. | Max. | Units | Test Condition |
|---|---|---|---|---|---|---|
| $BV_{DSS}$ | Drain-Source Breakdown Voltage | 100 | -- | -- | V | $V_{GS}$=0V,$I_D$=250μA |
| $\Delta BV/\Delta T_J$ | Breakdown Voltage Temp. Coeff. | -- | 0.12 | -- | V/℃ | $I_D$=250μA ***See Fig 7*** |
| $V_{GS(th)}$ | Gate Threshold Voltage | 2.0 | -- | 4.0 | V | $V_{DS}$=5V,$I_D$=250μA |
| $I_{GSS}$ | Gate-Source Leakage , Forward | -- | -- | 100 | nA | $V_{GS}$=20V |
| | Gate-Source Leakage , Reverse | -- | -- | -100 | | $V_{GS}$=-20V |
| $I_{DSS}$ | Drain-to-Source Leakage Current | -- | -- | 1 | μA | $V_{DS}$=30V ⑥ |
| | | -- | -- | 10 | | $V_{DS}$=100V |
| | | -- | -- | 100 | | $V_{DS}$=80V,$T_A$=125℃ |
| $R_{DS(on)}$ | Static Drain-Source On-State Resistance | -- | -- | 0.2 | Ω | $V_{GS}$=10V,$I_D$=1.15A ④ |
| $g_{fs}$ | Forward Transconductance | -- | 3.12 | -- | S | $V_{DS}$=40V,$I_D$=1.15A ④ |
| $C_{iss}$ | Input Capacitance | -- | 370 | 480 | pF | $V_{GS}$=0V,$V_{DS}$=25V,f =1MHz ***See Fig 5*** |
| $C_{oss}$ | Output Capacitance | -- | 95 | 110 | | |
| $C_{rss}$ | Reverse Transfer Capacitance | -- | 38 | 45 | | |
| $t_{d(on)}$ | Turn-On Delay Time | -- | 14 | 40 | ns | $V_{DD}$=50V,$I_D$=9.2A, $R_G$=18Ω ***See Fig 13*** ④ ⑤ |
| $t_r$ | Rise Time | -- | 14 | 40 | | |
| $t_{d(off)}$ | Turn-Off Delay Time | -- | 36 | 90 | | |
| $t_f$ | Fall Time | -- | 28 | 70 | | |
| $Q_g$ | Total Gate Charge | -- | 16 | 22 | nC | $V_{DS}$=80V,$V_{GS}$=10V, $I_D$=9.2A ***See Fig 6 & Fig 12*** ④ ⑤ |
| $Q_{gs}$ | Gate-Source Charge | -- | 2.7 | -- | | |
| $Q_{gd}$ | Gate-Drain("Miller") Charge | -- | 7.8 | -- | | |

## Source-Drain Diode Ratings and Characteristics

| Symbol | Characteristic | Min. | Typ. | Max. | Units | Test Condition |
|---|---|---|---|---|---|---|
| $I_S$ | Continuous Source Current | -- | -- | 2.3 | A | Integral reverse pn-diode in the MOSFET |
| $I_{SM}$ | Pulsed-Source Current ① | -- | -- | 18 | | |
| $V_{SD}$ | Diode Forward Voltage ④ | -- | -- | 1.5 | V | $T_J$=25℃,$I_S$=2.3A,$V_{GS}$=0V |
| $t_{rr}$ | Reverse Recovery Time | -- | 98 | -- | ns | $T_J$=25℃,$I_F$=9.2A |
| $Q_{rr}$ | Reverse Recovery Charge | -- | 0.34 | -- | μC | $di_F/dt$=100A/μs ④ |

**Notes ;**

① Repetitive Rating : Pulse Width Limited by Maximum Junction Temperature

② L=35mH, $I_{AS}$=2.3A, $V_{DD}$=25V, $R_G$=27Ω, Starting $T_J$=25℃

③ $I_{SD}$≤9.2A, di/dt≤300A/μs, $V_{DD}$≤$BV_{DSS}$ , Starting $T_J$=25℃

④ Pulse Test : Pulse Width = 250μs, Duty Cycle ≤ 2%

⑤ Essentially Independent of Operating Temperature

⑥ Adjusted for Cisco

**Fig 1. Output Characteristics**

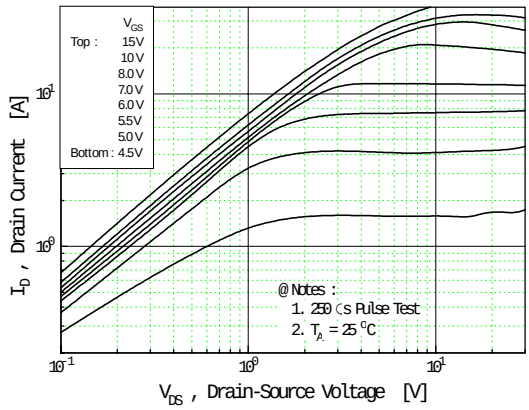



**Fig 2. Transfer Characteristics**

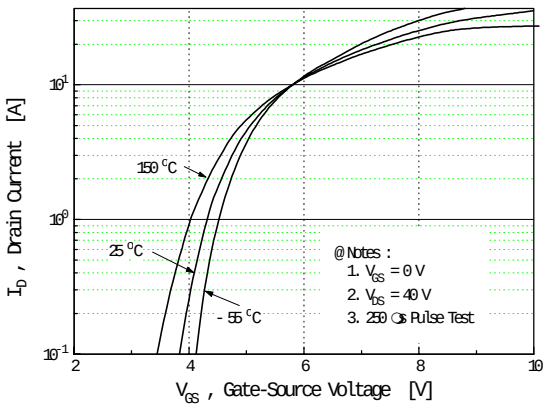



**Fig 3. On-Resistance vs. Drain Current**

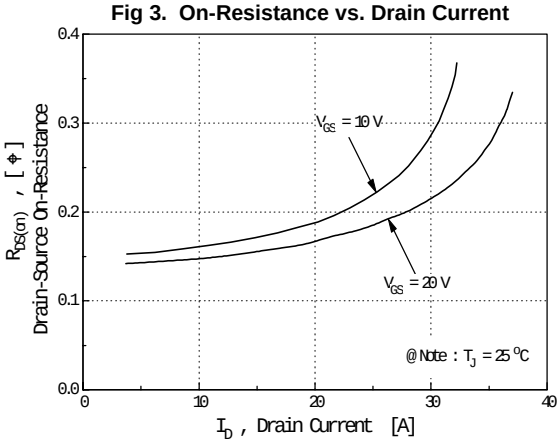



**Fig 4. Source-Drain Diode Forward Voltage**

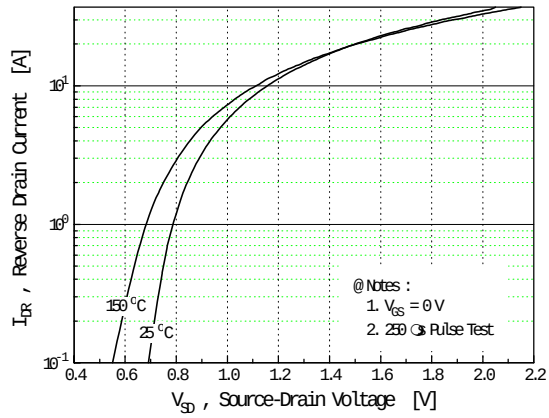



**Fig 5. Capacitance vs. Drain-Source Voltage**

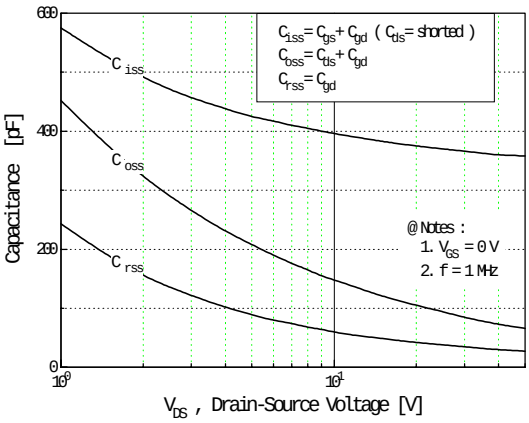



**Fig 6. Gate Charge vs. Gate-Source Voltage**

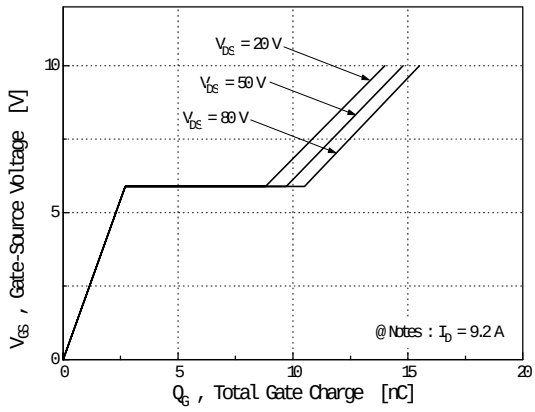


**Fig 7. Breakdown Voltage vs. Temperature**

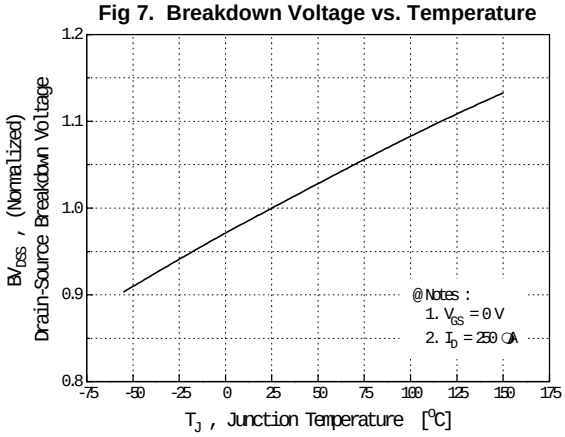



**Fig 8. On-Resistance vs. Temperature**

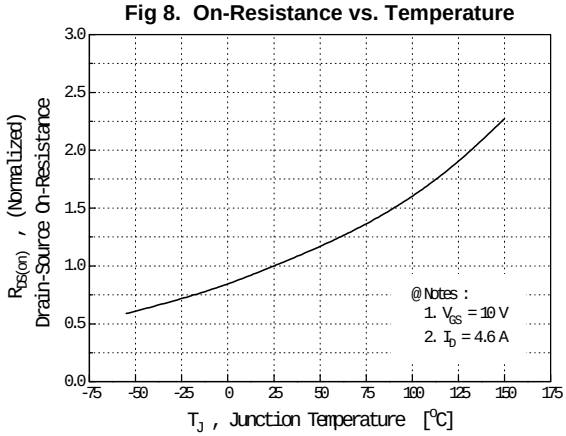



**Fig 9. Max. Safe Operating Area**

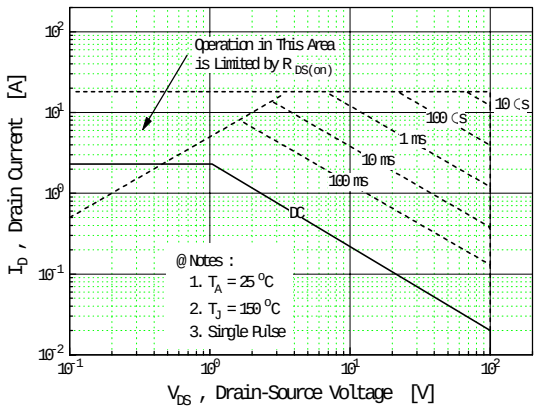



**Fig 10. Max. Drain Current vs. Ambient Temperature**

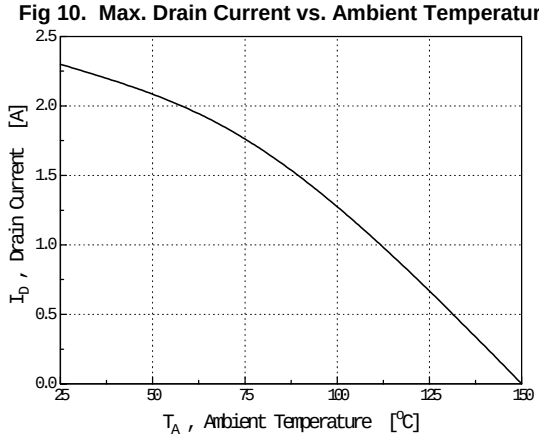



**Fig 11. Thermal Response**

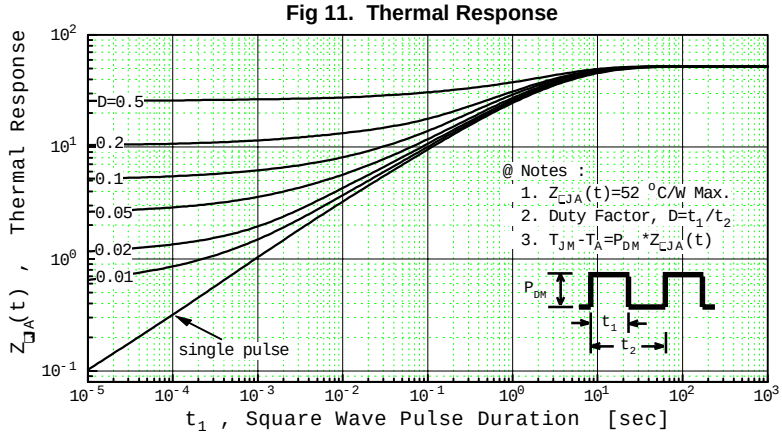


**Fig 12. Gate Charge Test Circuit & Waveform**

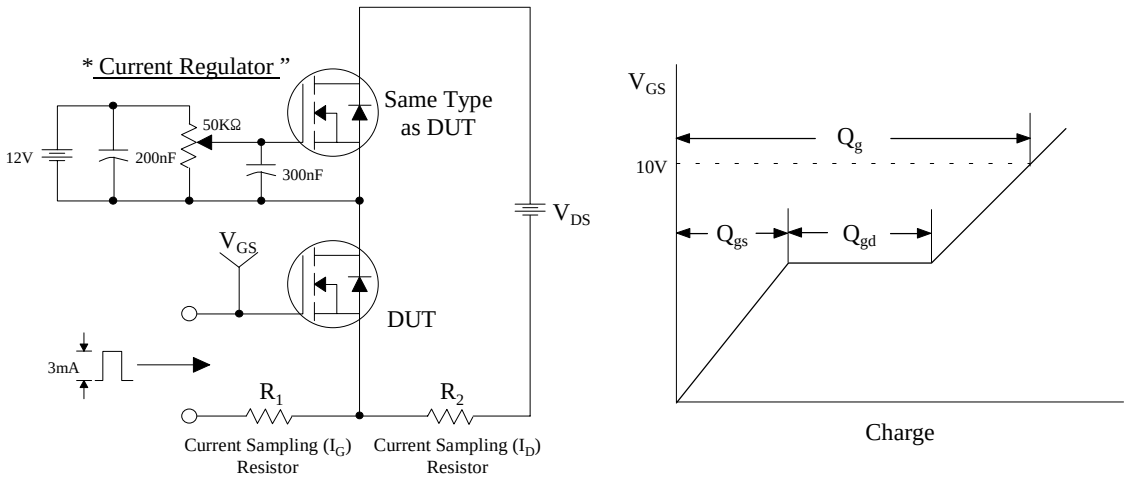



**Fig 13. Resistive Switching Test Circuit & Waveforms**

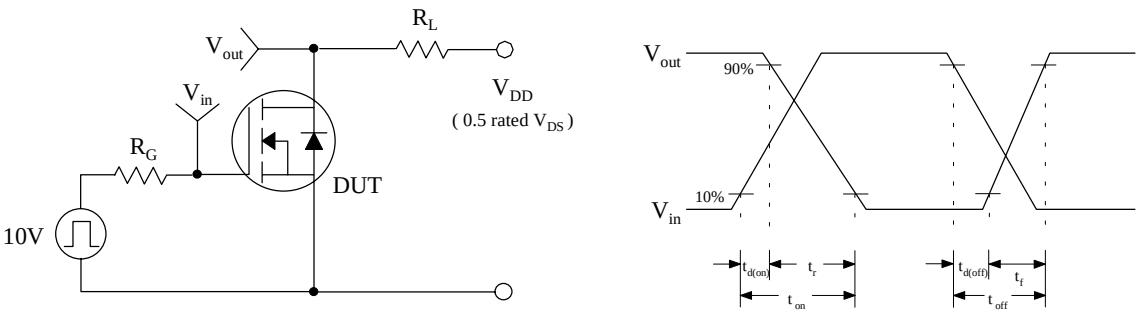



**Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms**

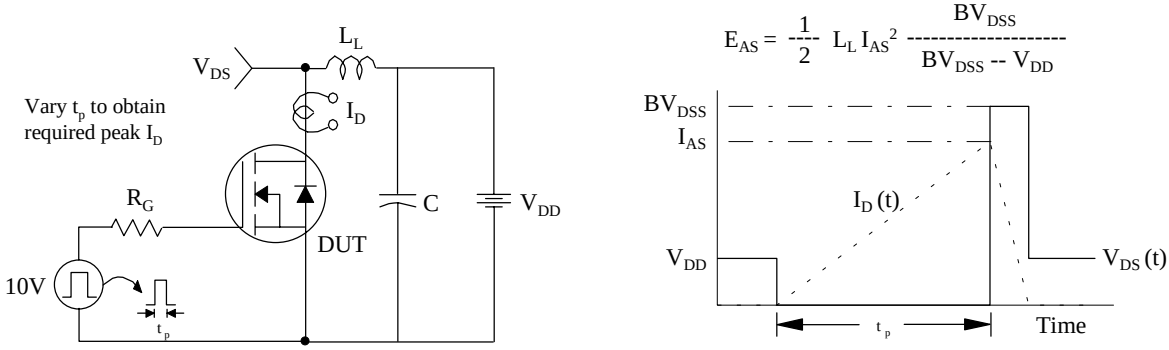
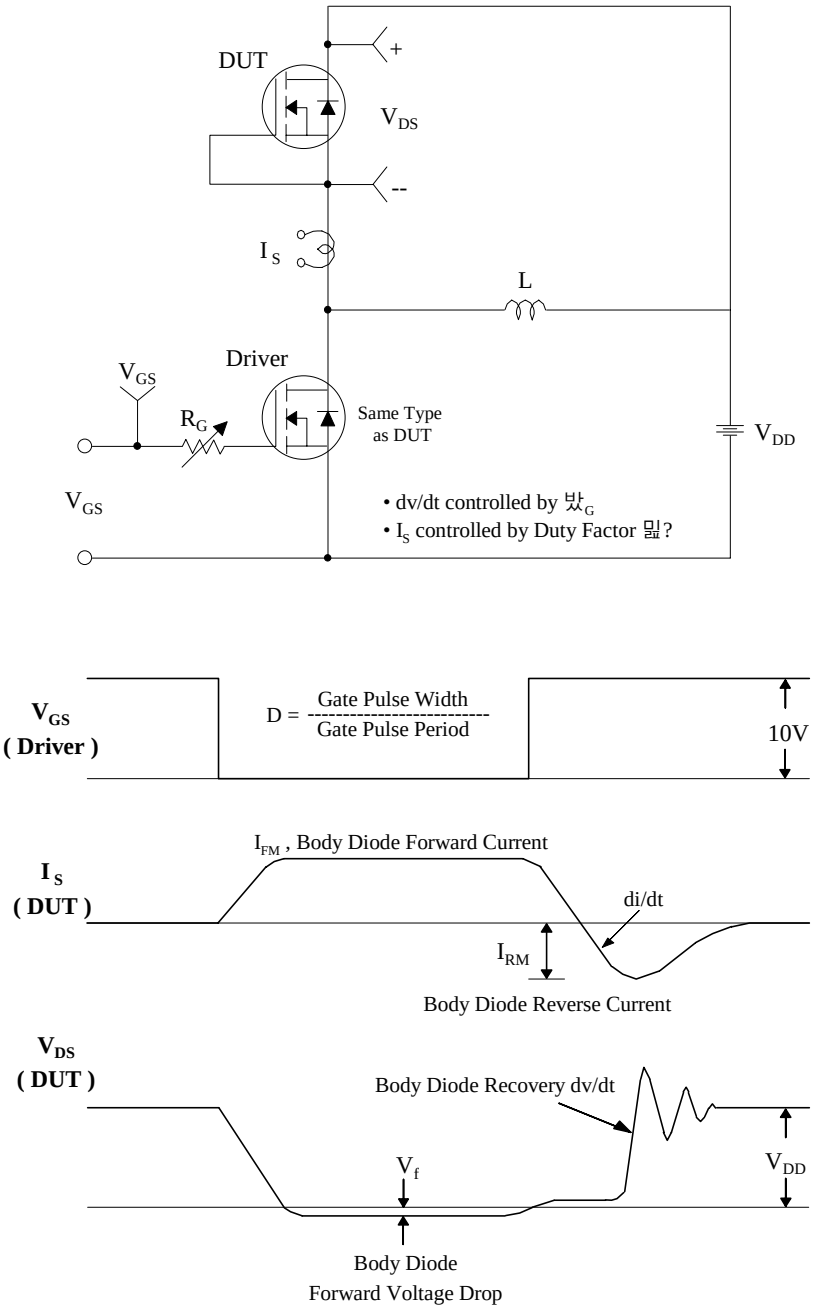


**Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms**



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